Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/805,158	ONO ET AL.	ONO ET AL.
Examiner	Art Unit	Art Unit

2814

Marcos D. Pizarro-Crespo

SEARCHED					
Class	Subclass	Date	Examiner		
257	288,295 310,314 324-326 410,411				
438	287,288	9/6/2006	MDP		

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST search for paper no. 0705 made of record.	7/14/2005	MDP		
IEEE Xplore search for paper no. 0705 made of record.	7/14/2005	MDP		
Updated EAST search for paper no. 11/05 made of record.	11/14/2005	mdp		
Updated EAST search for paper no. 3/2006.	2/28/2006	MDP		
Updated EAST search for paper no. 9/2006.	9/6/2006	MDP		
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